Annex A3

Laboratory analysis of soil samples for Polychlorinated Biphenyl (PCBs) & Polychlorinated dibenzo-p-dioxins and dibenzofurans (PCDD/Fs)

A3.1 PURPOSE AND APPROACH

A3.1.1 PURPOSE OF THE ANALYSIS

To reassure the soil underneath the concrete pavement is not contaminated with Polychlorinated Biphenyl (PCBs) and Polychlorinated dibenzo-p-dioxins & dibenzofurans (PCDD/Fs) due to the operation of the CCPP.

A3.1.2 SOIL SAMPLING & TESTING

The site investigation was conducted during 21 to 22 February 2008. Soil samples were obtained from 6 sampling locations within the CCPP site (plus one QC sample). Soil sampling locations can be referred to Contamination Assessment Plan (CAP) and Contamination Assessment Report (CAR). At each location, soil samples are collected underneath the concrete pavement and at 1.5m below ground.

For the PCBs and PCDD/Fs testing, soil samples obtained from areas next to the rotary kiln, cyclone and the MRF building (where the residues are temporary stored after the completion of the trial) are analysed as these areas have the highest potential of dioxins contamination (if any) due to operation of the CCPP or release of the residues. As the CCPP has only operated for a very short period, it is considered adequate to analyse the samples collected underneath the concrete pavement.

A total of 3 soil samples will be analysed for dioxins (ie Samples S1, S5 and S7, please refer to *Figure 3.1a* of the CAR). The samples were sent to accredited chemical analysis laboratory for PCBs and PCDD/Fs testing.

A3.2 LABORATORY ANALYSIS RESULTS

The Laboratory analysis reports are attached in this *Annex*. Levels of PCBs, dioxins and furans analysed in all samples were well below the RBRG values for soil in industrial area. Detailed discussion and land contamination assessment should be referred to the *Chapter 4* of the *EIA Report*.

Annex No. 1 to test Report No. 12194/1/2008

Sample: HK0802860-1 S1

1. Measurement results PCDD/F:

Sample:	HK0802860-1 S1				
			Final extract [µl]:		75
Sample weight [g]:	5.240		Injection volume [µl]:		2
Dry matter [%]:	91.9		Acquisition date [d.m.y h:m]:		12.6.08 20:59
2,3,7,8-PCDD/Fs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]I-TEFs	I-TEQ [ng/g dw]
2,3,7,8-TCDD	0.0087	0.00030	0.00060	1	0.0087
1,2,3,7,8-PeCDD	0.026	0.00047	0.00094	0.5	0.013
1,2,3,4,7,8-HxCDD	0.015	0.00078	0.0016	0.1	0.0015
1,2,3,6,7,8-HxCDD	0.025	0.00078	0.0016	0.1	0.0025
1,2,3,7,8,9-HxCDD	0.021	0.00078	0.0016	0.1	0.0021
1,2,3,4,6,7,8-HpCDD	0.11	0.00088	0.0018	0.01	0.0011
OCDD	0.14	0.0015	0.0029	0.001	0.00014
2,3,7,8-TCDF	0.11	0.00033	0.00065	0.1	0.011
1,2,3,7,8-PeCDF	0.094	0.00047	0.00095	0.05	0.0047
2,3,4,7,8-PeCDF	0.11	0.00047	0.00095	0.5	0.053
1,2,3,4,7,8-HxCDF	0.08	0.00088	0.0018	0.1	0.0080
1,2,3,6,7,8-HxCDF	0.076	0.00088	0.0018	0.1	0.0076
1,2,3,7,8,9-HxCDF	0.0063	0.00088	0.0018	0.1	0.00063
2,3,4,6,7,8-HxCDF	0.044	0.00088	0.0018	0.1	0.0044
1,2,3,4,6,7,8-HpCDF	0.17	0.0010	0.0020	0.01	0.0017
1,2,3,4,7,8,9-HpCDF	0.015	0.0010	0.0020	0.01	0.00015
OCDF	0.023	0.0011	0.0021	0.001	0.000023
I-TEQ from quantified 2,3,7,8-PCDD/Fs [ng 2,3,7,8-TCDD/g dw]-"Lowerbound"					**0.12**
I-TEQ from quantified 2,3,7,8-PCDDs [ng 2,3,7,8-TCDD/g dw]					0.029
I-TEQ from quantified 2,3,7,8-PCDFs [ng 2,3,7,8-TCDD/g dw]					0.092
I-TEQ from n.d. and non quantified 2,3,7,8-PCDD/Fs [ng 2,3,7,8-TCDD/g dw]					0
Maximum possible I-TEQ [ng 2,3,7,8-TCDD/g dw]-"Upperbound"					**0.12**

PCDDs	Content [ng/g dw]	**PCDFs**	Content [ng/g dw]
Tetra-CDDs	0.62	Tetra-CDFs	4.4
Penta-CDDs	0.68	Penta-CDFs	1.9
Hexa-CDDs	0.57	Hexa-CDFs	0.80
Hepta-CDDs	0.23	Hepta-CDFs	0.24
OCDD	0.14	OCDF	0.023
Total PCDDs	**2.2**	**Total PCDFs**	**7.4**

[1]I-TEF according to NATO.

The limits of quantification are defined as the double of the detection limits.

The limit of detection is defined as the amount of analyte producing a signal with S/N≥3.

The value of the detection limit is mentioned as the actual value at the acquisition date.

Measurement uncertainty is expressed as a double (k=2) relative standard deviation (RSD%), and corresponds to 95% interval of reliability.

Estimation of uncertainty of each 2,3,7,8-PCDD/F congener is 30% and total I-TEQ is 20%.

These values were ensured by analyses of certified reference material under conditions of internal reproducibility. Results marked "<" are situated in the interval of the limit of detection and the limit of quantification and are not quantified.

Results marked "n.d." are lower than the limit of detection.

"Lowerbound" and "Upperbound" are levels defined in Directive 2002/69/EC and 2002/70/EC.

Annex No. 1 to test Report No. 12194/1/2008

2. Measurement results PCB:

Sample:	HK0802860-1 S1		Final extract [µl]:		750
Sample weight [g]:	5.240		Injection volume [µl]:		2
Dry matter [%]:	91.9		Acquisition date [d.m.y h:m]:		12.6.08 22:01
mono- and di-orthoPCBs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]TEFs	TEQ [ng/g dw]
PCB #105	< 0.13	0.0023	0.13	0.0001	0
PCB #114	< 0.017	0.0027	0.017	0.0005	0
PCB #118	< 0.17	0.0024	0.17	0.0001	0
PCB #123	< 0.0082	0.0027	0.0082	0.0001	0
PCB #156	< 0.058	0.0033	0.058	0.0005	0
PCB #157	< 0.014	0.0034	0.014	0.0005	0
PCB #167	< 0.022	0.0033	0.022	0.00001	0
PCB #170	< 0.020	0.0068	0.020	0.0001	0
PCB #180	< 0.058	0.0051	0.058	0.00001	0
PCB #189	n.d.	0.0051	0.010	0.0001	0
Total TEQ from quantified mono- and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0**
TEQ from n.d. and non quantified mono- and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					0.000078
Maximum possible TEQ from mono-and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.000078**

Sample:	HK0802860-1 S1		Final extract [µl]:		750
Sample weight [g]:	5.240		Injection volume [µl]:		2
Dry matter [%]:	91.9		Acquisition date [d.m.y h:m]:		12.6.08 22:01
non-orthoPCBs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]TEFs	TEQ [ng/g dw]
PCB #77	0.31	0.0024	0.091	0.0005	0.00015
PCB #81	0.044	0.0024	0.0048	-	-
PCB #126	0.095	0.0023	0.0047	0.1	0.0095
PCB #169	0.011	0.0040	0.0079	0.01	0.00011
Total TEQ from quantified non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.0097**
TEQ from n.d. and non quantified non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					0
Maximum possible TEQ from non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.0097**

[1]TEFs according to Ahlborg et al. 1994; Chemosphere, Vol. 28, No. 6, 1049-1067.

The limits of quantification are defined on the base of blank level or as double of the detection limits.

The limit of detection is defined as the amount of analyte producing a signal with S/N≥3.

The value of the detection limit is mentioned as the actual value at the acquisition date.

Measurement uncertainty is expressed as a double (k=2) relative standard deviation (RSD%), and corresponds to 95% interval of reliability.

Estimation of uncertainty of each PCB congener is 30% and total TEQ is 20%.

These values were ensured by analyses of certified reference material under conditions of internal reproducibility. Results marked "<" are situated in the interval of the limit of detection and the limit of quantification and are not quantified.

Results marked "n.d." are lower than the limit of detection.

"Lowerbound" and "Upperbound" are levels defined in Directive 2002/69/EC and 2002/70/EC.

Annex No. 1 to test Report No. 12194/1/2008

Sample: HK0802860-5 S5

1. Measurement results PCDD/F:

Sample:	HK0802860-5 S5				
			Final extract [µl]:		75
Sample weight [g]:	4.755		Injection volume [µl]:		2
Dry matter [%]:	92.3		Acquisition date [d.m.y h:m]:		12.6.08 23:13
2,3,7,8-PCDD/Fs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]I-TEFs	I-TEQ [ng/g dw]
2,3,7,8-TCDD	n.d.	0.00035	0.00070	1	0
1,2,3,7,8-PeCDD	0.0015	0.00063	0.0013	0.5	0.00076
1,2,3,4,7,8-HxCDD	< 0.0019	0.00093	0.0019	0.1	0
1,2,3,6,7,8-HxCDD	0.0030	0.00093	0.0019	0.1	0.00030
1,2,3,7,8,9-HxCDD	0.0020	0.00093	0.0019	0.1	0.00020
1,2,3,4,6,7,8-HpCDD	0.018	0.0011	0.0022	0.01	0.00018
OCDD	0.23	0.0020	0.0039	0.001	0.00023
2,3,7,8-TCDF	0.0053	0.00042	0.00083	0.1	0.00053
1,2,3,7,8-PeCDF	0.0039	0.00059	0.0012	0.05	0.00020
2,3,4,7,8-PeCDF	0.0048	0.00059	0.0012	0.5	0.0024
1,2,3,4,7,8-HxCDF	0.0032	0.0010	0.0020	0.1	0.00032
1,2,3,6,7,8-HxCDF	0.0028	0.0010	0.0020	0.1	0.00028
1,2,3,7,8,9-HxCDF	n.d.	0.0010	0.0020	0.1	0
2,3,4,6,7,8-HxCDF	< 0.0020	0.0010	0.0020	0.1	0
1,2,3,4,6,7,8-HpCDF	0.0098	0.0012	0.0024	0.01	0.000098
1,2,3,4,7,8,9-HpCDF	n.d.	0.0012	0.0024	0.01	0
OCDF	0.0033	0.0014	0.0029	0.001	0.0000033
I-TEQ from quantified 2,3,7,8-PCDD/Fs [ng 2,3,7,8-TCDD/g dw]-"Lowerbound"					**0.0055**
I-TEQ from quantified 2,3,7,8-PCDDs [ng 2,3,7,8-TCDD/g dw]					0.0017
I-TEQ from quantified 2,3,7,8-PCDFs [ng 2,3,7,8-TCDD/g dw]					0.0038
I-TEQ from n.d. and non quantified 2,3,7,8-PCDD/Fs [ng 2,3,7,8-TCDD/g dw]					0.00085
Maximum possible I-TEQ [ng 2,3,7,8-TCDD/g dw]-"Upperbound"					**0.0063**

PCDDs	Content [ng/g dw]	**PCDFs**	Content [ng/g dw]
Tetra-CDDs	0.040	Tetra-CDFs	0.21
Penta-CDDs	0.069	Penta-CDFs	0.091
Hexa-CDDs	0.074	Hexa-CDFs	0.035
Hepta-CDDs	0.038	Hepta-CDFs	0.014
OCDD	0.23	OCDF	0.0033
Total PCDDs	**0.45**	**Total PCDFs**	**0.35**

[1]I-TEF according to NATO.

The limits of quantification are defined as the double of the detection limits.

The limit of detection is defined as the amount of analyte producing a signal with S/N≥3.

The value of the detection limit is mentioned as the actual value at the acquisition date.

Measurement uncertainty is expressed as a double (k=2) relative standard deviation (RSD%), and corresponds to 95% interval of reliability.

Estimation of uncertainty of each 2,3,7,8-PCDD/F congener is 30% and total I-TEQ is 20%.

These values were ensured by analyses of certified reference material under conditions of internal reproducibility. Results marked "<" are situated in the interval of the limit of detection and the limit of quantification and are not quantified.

Results marked "n.d." are lower than the limit of detection.

"Lowerbound" and "Upperbound" are levels defined in Directive 2002/69/EC and 2002/70/EC.

Annex No. 1 to test Report No. 12194/1/2008

2. Measurement results PCB:

Sample:	HK0802860-5 S5		Final extract [µl]:		750
Sample weight [g]:	4.755		Injection volume [µl]:		2
Dry matter [%]:	92.3		Acquisition date [d.m.y h:m]:		13.6.08 0:15
mono- and di-orthoPCBs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]TEFs	TEQ [ng/g dw]
PCB #105	< 0.034	0.0022	0.034	0.0001	0
PCB #114	n.d.	0.0025	0.0050	0.0005	0
PCB #118	< 0.089	0.0023	0.089	0.0001	0
PCB #123	n.d.	0.0025	0.0051	0.0001	0
PCB #156	< 0.012	0.0031	0.012	0.0005	0
PCB #157	n.d.	0.0033	0.0067	0.0005	0
PCB #167	< 0.0072	0.0031	0.0072	0.00001	0
PCB #170	< 0.030	0.0064	0.030	0.0001	0
PCB #180	< 0.068	0.0048	0.068	0.00001	0
PCB #189	n.d.	0.0053	0.011	0.0001	0
Total TEQ from quantified mono- and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0**
TEQ from n.d. and non quantified mono- and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					0.000026
Maximum possible TEQ from mono-and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.000026**

Sample:	HK0802860-5 S5		Final extract [µl]:		750
Sample weight [g]:	4.755		Injection volume [µl]:		2
Dry matter [%]:	92.3		Acquisition date [d.m.y h:m]:		13.6.08 0:15
non-orthoPCBs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]TEFs	TEQ [ng/g dw]
PCB #77	< 0.040	0.0023	0.040	0.0005	0
PCB #81	n.d.	0.0022	0.0045	-	-
PCB #126	< 0.0051	0.0025	0.0051	0.1	0
PCB #169	n.d.	0.0052	0.010	0.01	0
Total TEQ from quantified non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0**
TEQ from n.d. and non quantified non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					0.00058
Maximum possible TEQ from non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.00058**

[1]TEFs according to Ahlborg et al. 1994; Chemosphere, Vol. 28, No. 6, 1049-1067.

The limits of quantification are defined on the base of blank level or as double of the detection limits.

The limit of detection is defined as the amount of analyte producing a signal with S/N≥3.

The value of the detection limit is mentioned as the actual value at the acquisition date.

Measurement uncertainty is expressed as a double (k=2) relative standard deviation (RSD%), and corresponds to 95% interval of reliability.

Estimation of uncertainty of each PCB congener is 30% and total TEQ is 20%.

These values were ensured by analyses of certified reference material under conditions of internal reproducibility. Results marked "<" are situated in the interval of the limit of detection and the limit of quantification and are not quantified.

Results marked "n.d." are lower than the limit of detection.

"Lowerbound" and "Upperbound" are levels defined in Directive 2002/69/EC and 2002/70/EC.

Annex No. 1 to test Report No. 12194/1/2008

Sample: HK0802860-71 S7

1. Measurement results PCDD/F:

Sample:	HK0802860-7 S7				
			Final extract [µl]:		75
Sample weight [g]:	4.951		Injection volume [µl]:		2
Dry matter [%]:	83.6		Acquisition date [d.m.y h:m]:		13.6.08 1:27
2,3,7,8-PCDD/Fs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]I-TEFs	I-TEQ [ng/g dw]
2,3,7,8-TCDD	< 0.00081	0.00040	0.00081	1	0
1,2,3,7,8-PeCDD	0.0019	0.00063	0.0013	0.5	0.00095
1,2,3,4,7,8-HxCDD	< 0.0020	0.0010	0.0020	0.1	0
1,2,3,6,7,8-HxCDD	0.0023	0.0010	0.0020	0.1	0.00023
1,2,3,7,8,9-HxCDD	< 0.0020	0.0010	0.0020	0.1	0
1,2,3,4,6,7,8-HpCDD	0.014	0.0013	0.0025	0.01	0.00014
OCDD	0.20	0.0020	0.0040	0.001	0.00020
2,3,7,8-TCDF	0.0087	0.00045	0.0009	0.1	0.00087
1,2,3,7,8-PeCDF	0.0056	0.00062	0.0012	0.05	0.00028
2,3,4,7,8-PeCDF	0.0065	0.00062	0.0012	0.5	0.0033
1,2,3,4,7,8-HxCDF	0.0058	0.0012	0.0024	0.1	0.00058
1,2,3,6,7,8-HxCDF	0.0053	0.0012	0.0024	0.1	0.00053
1,2,3,7,8,9-HxCDF	n.d.	0.0012	0.0024	0.1	0
2,3,4,6,7,8-HxCDF	0.0031	0.0012	0.0024	0.1	0.00031
1,2,3,4,6,7,8-HpCDF	0.017	0.0014	0.0028	0.01	0.00017
1,2,3,4,7,8,9-HpCDF	n.d.	0.0014	0.0028	0.01	0
OCDF	0.0042	0.0015	0.0029	0.001	0.0000042
I-TEQ from quantified 2,3,7,8-PCDD/Fs [ng 2,3,7,8-TCDD/g dw]-"Lowerbound"					**0.0075**
I-TEQ from quantified 2,3,7,8-PCDDs [ng 2,3,7,8-TCDD/g dw]					0.0015
I-TEQ from quantified 2,3,7,8-PCDFs [ng 2,3,7,8-TCDD/g dw]					0.0060
I-TEQ from n.d. and non quantified 2,3,7,8-PCDD/Fs [ng 2,3,7,8-TCDD/g dw]					0.0013
Maximum possible I-TEQ [ng 2,3,7,8-TCDD/g dw]-"Upperbound"					**0.0089**

PCDDs	Content [ng/g dw]	**PCDFs**	Content [ng/g dw]
Tetra-CDDs	0.039	Tetra-CDFs	0.29
Penta-CDDs	0.050	Penta-CDFs	0.13
Hexa-CDDs	0.048	Hexa-CDFs	0.059
Hepta-CDDs	0.032	Hepta-CDFs	0.023
OCDD	0.20	OCDF	0.0042
Total PCDDs	**0.37**	**Total PCDFs**	**0.51**

[1]I-TEF according to NATO.

The limits of quantification are defined as the double of the detection limits.

The limit of detection is defined as the amount of analyte producing a signal with S/N≥3.

The value of the detection limit is mentioned as the actual value at the acquisition date.

Measurement uncertainty is expressed as a double (k=2) relative standard deviation (RSD%), and corresponds to 95% interval of reliability.

Estimation of uncertainty of each 2,3,7,8-PCDD/F congener is 30% and total I-TEQ is 20%.

These values were ensured by analyses of certified reference material under conditions of internal reproducibility. Results marked "<" are situated in the interval of the limit of detection and the limit of quantification and are not quantified.

Results marked "n.d." are lower than the limit of detection.

"Lowerbound" and "Upperbound" are levels defined in Directive 2002/69/EC and 2002/70/EC.

Annex No. 1 to test Report No. 12194/1/2008

2. Measurement results PCB:

Sample:	HK0802860-7 S7		Final extract [µl]:		750
Sample weight [g]:	4.951		Injection volume [µl]:		2
Dry matter [%]:	83.6		Acquisition date [d.m.y h:m]:		13.6.08 2:29
mono- and di-orthoPCBs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]TEFs	TEQ [ng/g dw]
PCB #105	< 0.041	0.0026	0.041	0.0001	0
PCB #114	n.d.	0.0030	0.0059	0.0005	0
PCB #118	< 0.096	0.0027	0.096	0.0001	0
PCB #123	n.d.	0.0030	0.0059	0.0001	0
PCB #156	< 0.017	0.0034	0.017	0.0005	0
PCB #157	n.d.	0.0036	0.0071	0.0005	0
PCB #167	< 0.0075	0.0034	0.0075	0.00001	0
PCB #170	< 0.024	0.0071	0.024	0.0001	0
PCB #180	< 0.071	0.0053	0.071	0.00001	0
PCB #189	n.d.	0.0051	0.010	0.0001	0
Total TEQ from quantified mono- and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0**
TEQ from n.d. and non quantified mono- and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					0.000029
Maximum possible TEQ from mono-and di-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.000029**

Sample:	HK0802860-7 S7		Final extract [µl]:		750
Sample weight [g]:	4.951		Injection volume [µl]:		2
Dry matter [%]:	83.6		Acquisition date [d.m.y h:m]:		13.6.08 2:29
non-orthoPCBs	Content [ng/g dw]	Limit of Detection [ng/g dw]	Limit of Quantification [ng/g dw]	[1]TEFs	TEQ [ng/g dw]
PCB #77	< 0.057	0.0026	0.057	0.0005	0
PCB #81	n.d.	0.0025	0.0050	-	-
PCB #126	< 0.0053	0.0026	0.0053	0.1	0
PCB #169	n.d.	0.0048	0.010	0.01	0
Total TEQ from quantified non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0**
TEQ from n.d. and non quantified non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					0.00061
Maximum possible TEQ from non-ortho PCBs [ng 2,3,7,8-TCDD/g dw]					**0.00061**

[1]TEFs according to Ahlborg et al. 1994; Chemosphere, Vol. 28, No. 6, 1049-1067.

The limits of quantification are defined on the base of blank level or as double of the detection limits.

The limit of detection is defined as the amount of analyte producing a signal with S/N≥3.

The value of the detection limit is mentioned as the actual value at the acquisition date.

Measurement uncertainty is expressed as a double (k=2) relative standard deviation (RSD%), and corresponds to 95% interval of reliability.

Estimation of uncertainty of each PCB congener is 30% and total TEQ is 20%.

These values were ensured by analyses of certified reference material under conditions of internal reproducibility. Results marked "<" are situated in the interval of the limit of detection and the limit of quantification and are not quantified.

Results marked "n.d." are lower than the limit of detection.

"Lowerbound" and "Upperbound" are levels defined in Directive 2002/69/EC and 2002/70/EC.

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Test Report No. 12194 / 1 / 2008

Prague : 22.7.2008

Project: Shipment No.: 941708519728
Date of sampling: 22.2.2008
Date of receipt: 9.6.2008
Sampling procedure: Sampling was performed by the client
Date of test performance: 9.6. - 16.6.2008
Place of test performance: ALS Czech Republic, s.r.o., Laboratoř HRMS, V Ráji 906, 530 02 Pardubice
Test specification, deviations, additions to or exclusions from the test specification and any other information:

D06_06_173 Determination of sum PCB and planar congeners PCB by HRMS by internal instruction. Analysed by HRGC/HRMS syst. - Agilent 6890N/Finnigan MAT 95XP resp. Trace GC Ultra/DFS. Resol. HRMS: 10000. GC column: RTX-500 60 m, 0,25 mm ID; film 0,1 µm

D06_06_175 Determination of polychlorinated dibenzo-p-dioxins and dibenzofurans according to US EPA 1613. Analysed by technique: HRGC/HRMS system - Agilent 6890N/Finnigan MAT 95XP resp. Trace GC Ultra/DFS. Resolution HRMS: 10000

Measurement results

sample name	HK0802860-1 S1		HK0802860-5 S5		HK0802860-7 S7				
matrix	soil		soil		soil				
parameter	**result**	**MU**	**result**	**MU**	**result**	**MU**	**unit**	**test specification**	
Dry matter at 105 °C	91,9	±2	92,3	±2	83,6	±2	%	D06_06_175	A
I-TEQ (PCDD/F) lowerbound	0,12	±20	0,0055	±20	0,0075	±20	ng/g dw	D06_06_175	A
I-TEQ (PCDD/F) upperbound	0,12		0,0063		0,0089		ng/g dw	D06_06_175	A
I-TEQ (PCB) lowerbound	0,0097	±20	0	±20	0	±20	ng/g dw	D06_06_173	A
I-TEQ (PCB) upperbound	0,0098		0,00061		0,00064		ng/g dw	D06_06_173	A

TESTING LABORATORY ACCREDITED BY CAI ALS Czech Republic s r o č. 1163

Ing. Emilie Pokorna
Quality Manager

Measurement uncertainty (MU [%]) is expressed as expanded measurement uncertainty with coverage factor k = 2, representing of 95 % significance level.
Parameters indexed by 'A' in the last column of the table are accredited, parameters indexed by 'N' are not accredited.